Chromium-Doped ZnO Nanoparticles Synthesized by Co-Precipitation: Chromium Effects

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ABSTRACT

The influence of chromium doping on the physical properties of ZnO nanoparticles synthesized using a low temperature co-precipitation technique is presented. In particular, we have studied the correlation between the structural and the magnetic properties as a function of chromium concentrations. In order to investigate the magnetic properties, vibrating sample magnetometry and electron spin resonance were employed. X-ray diffraction, energy-dispersive X-ray spectroscopy, Fourier transform infrared spectroscopy and UV-Vis spectroscopy were used. X-ray diffraction patterns of all the samples showed peaks consistent with a hexagonal wurtzite structure. The structure and composition analyses revealed that chromium is incorporated into the lattice structure, forming a solid solution instead of precipitates. All of the samples in this study exhibit ferromagnetic behavior. The implications of the effects of chromium are also discussed.

Keywords: Nanocrystalline ZnO Particles; Chromium; Room-Temperature-Ferromagnetic; ESR; Co-Precipitation

1. Introduction

The possibility to achieve both semiconducting and magnetic properties within a single material system by doping semiconducting materials with small concentrations of transition metals has spawned a new field of electronics known as spintronics [1-4]. The discovery of ferromagnetism at temperatures above 100 K in III-V-based ferromagnetic semiconductors such as Mn-doped GaAs has made it possible to fabricate spin injecting structures as well as structures for electrical or optical control of ferromagnetism [5-8]. However, most of the III-V-based ferromagnetic semiconductors have a highest Currie temperature (T_C) of 110 K, still far from room temperature, which is required for practical device applications [9-11].

Since Dietl et al. [12] predicted that p-type ZnO would be a promising candidate for high-T_C ferromagnetic semiconductors, there has been considerable research and progress on transition metal-doped ZnO for the realization of a room temperature T_C. Thereafter, there has been considerable research and progress on transition metal doped ZnO for the realization of a T_C at or above room temperature. Experimentally, room temperature ferromagnetism has been observed in Cr-, Mn-, Fe-, Co-, Ni-, and Cu-doped ZnO [13-18]. However, the results are inconsistent and controversial, both in experiments and in theory. This inconsistency suggests that room temperature ferromagnetism in transition metal-doped ZnO is highly sensitive to the synthesis procedures and conditions. Another suspicion is that ferromagnetism might be caused by a secondary phase, such as the doping elements or their oxides, rather than by the substitution of transition metal ions into Zn sites [19-21].

There are several theoretical explanations of the origin of room temperature ferromagnetism in transition metal-doped ZnO. Dietl et al. [12] first predicted that a high T_C for transition metal doped ZnO would require a large density of mobile holes to induce the ferromagnetic exchange interaction. However, a high concentration of hole is difficult to achieve due to the compensation of the wide band gap ZnO. Additionally, a theory cannot explain the RT ferromagnetism in n-type TM-doped ZnO. Therefore, Sato and Katayama-Yoshida [22] suggested a theory based on a combination of the Korringa-Kohn-Rostoker (KKR) method and the coherent potential approximation (CPA) to explain the origin of ferromagnetism in n-type TM-doped ZnO. Recently, Coey et al. [23] have argued that a carrier mediated exchange interaction cannot produce long-range magnetic order when...
the doping level of magnetic ions is only a few percent. They proposed a spin-split impurity band theory derived from the bound magnetic polarons (BMPs). In this model, the ferromagnetic exchange interaction is mediated by shallow donor electrons, which are treated in two-sublattice mean field approximation. The only remaining option to obtain a higher $T_C$ is to increase the donor electrons in the impurity band that will delocalize onto the TM ions.

Despite a number of reports available, confusion still persists on the existence and origin of room temperature ferromagnetism in transition metal doped ZnO. Hence, an attempt was made to reinvestigate Cr-doped ZnO. For synthesis, a co-precipitation method was chosen because it is cost effective, it requires low temperatures for processing, and it has a higher degree of solubility. The powder samples were characterized with regard to their composition, structure and phase (EDX, XRD, and UV-Vis), and magnetic properties (VSM and ESR).

2. Experimental

The following starting materials were used without further purification: zinc (II) sulfate (ZnSO$_4$·7H$_2$O, 99%, Merck) and chromium (III) chloride (CrCl$_3$·6H$_2$O, 99% Merck). To obtain the desired degree of doping of Cr, ZnSO$_4$·7H$_2$O was mixed in distilled water with CrCl$_3$·6H$_2$O. This solutions were designated as solution A. Solution A was placed in an ultrasonic cleaner operating at 57 kHz for 2 h. Solution B was obtained by adding 44 mmol of NaOH to 440 mL of de-ionized water. After sonication, solution A was mixed with a magnetic stirrer at room temperature, and solution B was added to solution A until a pH of 12 was reached. The resulting solution was magnetically stirred for 0.5 h, and then it was allowed to stand at room temperature for 18 h. Subsequently, the solution was centrifuged and washed several times with ethanol and distilled water to remove residual and unwanted impurities. The final product was dried in a vacuum oven at 200°C for 1 h to yield Cr-doped ZnO powder.

Elemental analyses of the samples were performed by energy dispersive X-ray (EDX) spectroscopy using a scanning electron microscope. Magnetic measurements were performed at room temperature using an Oxford Type 1.2 T vibrating sample magnetometer (VSM). The powder samples were tightly packed in a clear plastic drinking straw. Magnetization data were recorded as a function of an applied magnetic field, $0 \pm 1$T. The data reported in this study were corrected because background signals were introduced from the sample holder.

To evaluate the phase purity of the samples, X-ray diffraction (XRD) measurements were performed using a Philips PW 1710 and monochromatic Cu-Ka ($\lambda = 1.54060$ Å) radiation operated at 40 kV and 20 mA in the range of 10° to 80°. The instrumental broadening, including the instrumental symmetry, was calibrated using a Si powder standard. The X-ray diffraction patterns were analyzed by means of the MAUD program using Rietveld whole profile fitting to determine the crystal structure and lattice parameters.

To study the electronic interactions near the optical band gap resulting from the addition of dopant atoms, diffuse reflectance UV-Vis measurements were performed using a Shimadzu UV-Vis spectrophotometer with an integrating sphere and a spectral reflectance standard over a wavelength range of 250 - 800 nm. The diffuse reflectance, $R$, of the sample is related to the Kubelka-Munk function, $F(R)$, according to the following equation:

$$ F(R) = \left(1 - R\right)^2 / 2R $$

The energy band gap of the samples was calculated from the diffuse reflectance spectra by plotting the $F(R)^2$ as a function of energy and extrapolating to $F(R)^2 = 0$.

To obtain information regarding the oxidation state and site occupancy of the Cr ions in the ZnO matrix, electron spin resonance (ESR) was performed using an X-band JEOL JES-RE1X at room temperature and an X-band spectrometer equipped with a 9.1 GHz field modulation unit. The resonance was optimized for the modulation amplitude, receiver gain, time-constant and scan time. The amount of powder used in all measurements was the same. DPPH was used as the standard. The shape and area of the ESR spectra were analyzed using standard numerical methods.

3. Results and Discussion

3.1. Chemical Analysis

EDX measurement were used to determine the chemical composition of the Cr-doped ZnO samples. Figure 1 shows EDX spectra of the Cr-doped ZnO samples. The content of different elements in the sample can be observed in the spectra, confirming the incorporation of Cr atoms into the nanocrystalline ZnO particles. Calculating the area of the corresponding spectral K lines enabled quantitative characterization of the Cr/Zn ratios.

The amounts of Cr in the nanocrystalline ZnO particles were determined to vary between 3 and 16 at.%. The results were obtained by averaging four values from different regions of a sample. The inset of Figure 1 illustrates how the Cr incorporated into the nanocrystalline ZnO particles varied as a function of the initial cations ratio used in the synthesis. The EDX results indicate that the amounts of Cr incorporated in the samples were slightly lower than the amounts of Cr introduced in the synthesis.
3.2. Structural Characterization and Phase Evaluation

Typical XRD patterns of ZnO nanoparticles doped with Cr at different concentrations are shown in Figure 2. A pure wurtzite, single phase structure of ZnO can be obtained for all samples doped with Cr concentrations up to 16 at.%. No impurity peaks are detected, such as Cr$_2$O$_3$ and ZnCr$_2$O$_4$. This confirms that Cr dopant does not alter the crystal structure. However, the results of these data do not mean there is an absence of Cr clusters because we do not exclude the possibility of cluster formation below the detection limit of the X-ray diffractometer. The XRD data were further analyzed by the Rietveld technique, using the program MAUD [24].

The evolution of lattice parameter $a$, and $c$ and the unit cell volume, $V$, with doping concentrations are plotted in Figure 3. For the Cr-doped samples, the lattice constant decreases with increasing Cr concentration. Such a decrease of the lattice parameters in Cr-doped ZnO is quite obvious as the ionic radii of Cr ions are smaller than those of Zn.

3.3. Microstrain and Stress Analysis

It is known that the breadth of the XRD peak can be linked to the average crystallite size, microstrain and defects or dislocations. The average crystallite size using XRD measurements is not generally the same as the particle size due to powder aggregates. The average crystallite size as related to the line broadening can be calculated using Scherrer’s equation, as given in Equation (2):

$$\langle D \rangle = \frac{K}{(\beta \cos \theta)}$$  \hspace{1cm} (2)

where $\langle D \rangle =$ volume weighted crystallite size, $K =$ shape factor (close to unity in our work, it was set to 0.9), $\lambda =$ wavelength of Cu-K$_\alpha$, $b_{\text{id}} = \left[ \frac{b_{\text{id, measured}}^2 - b_{\text{instrumental}}^2}{\beta \cos \theta} \right]^{1/2}$ = instrumental corrected integral breadth of the reflection located at $2\theta$, and $\theta =$ angle of reflection. The average crystallite size for the Cr-doped ZnO calculated using Figure 3. The lattice parameters $a$, $c$, and cell volume $V$ of Cr-doped nanocrystalline ZnO particles as a function of doping concentration.
Scherrer’s equation is presented in Table 1.

The strain arising from crystal imperfections and distortions, such as vacancies and lattice deformations, can also induce a broadening in the XRD profile. Therefore, the line broadening is a combination of crystallite size and strain. Although the separation of these two phenomena is not straightforward, the contribution of each type of broadening can be determined by constructing a modified form of William and Hall (W-H) plot [25], namely UDM. In this form the strain was assumed to be uniform in all crystallographic direction, thus the material is considered to be isotropic. Strain-induced broadening is calculated by the equation:

\[ \beta_{hkl} = 4 \varepsilon \tan \theta \]  

where \( \varepsilon \) is the lattice strain.

The UDM approach considers the case of both the domain effect and lattice deformation operating simultaneously, and their combined effects give the final line broadening, which is the sum of Equation (2) and Equation (3):

\[ \beta_{hkl} \cos \theta = \frac{K}{\langle D \rangle} + 4 \varepsilon \sin \theta \]  

Rearranging the equation, the following equation can be obtained:

\[ \beta_{hkl} \cos \theta = \frac{K}{\langle D \rangle} + 4 \varepsilon \sin \theta \]  

By plotting the value of \( 4 \sin \theta \) along the x-axis and \( \beta_{hkl} \cos \theta \) along the y-axis, the lattice strain and the average crystallite size can be calculated through a linear fit. The UDM for Cr-doped ZnO are shown in Figure 4. It is clear that there is a decrease in the lattice strain with increasing doping concentrations. However, the UDM becomes less valid because the material properties vary with crystallographic directions. The other modified forms of the WH plot, that consider the anisotropic nature of the crystals are the uniform stress deformation model (USDM) and the uniform deformation energy density model (UDEDM). USDM and UDEDM give an idea of the stress-strain relation and the strain as a function of energy density, respectively. In USDM the anisotropic strain direction \( \varepsilon_{hkl} \) can be related with the deformation stress using Young’s modulus:

\[\sigma_{hkl} = E_{hkl} \varepsilon_{hkl}\]  

where \( E_{hkl} \) is Young’s modulus in the direction perpendicular to the \((hkl)\) plane and \( \varepsilon_{hkl} \) is the anisotropic lattice strain. In this model the WH equation becomes:

\[ \beta_{hkl} \cos \theta = \frac{K}{\langle D \rangle} + \frac{4 \sigma \sin \theta}{E_{hkl}} \]  

The deformation stress can be estimated from the slope of the linear fit of the graph which is plotted between \( \beta_{hkl} \cos \theta \) and \( 4 \sin \theta E_{hkl} \), and the crystallite size \( \langle D \rangle \) from the intercept. For samples with a hexagonal crystal phase, Young’s modulus \( E_{hkl} \) is related to:

\[ E_{hkl} = \frac{S_{11} \left( h^2 + \frac{(h + 2k)^2}{3} + \left( \frac{a}{c} \right)^2 \right) + S_{33} \left( \frac{a}{c} \right)^4 + \left( 2S_{13} + S_{44} \right) \left( \frac{h^2 + (h + 2k)^2}{3} + \left( \frac{a}{c} \right)^2 \right)}{S_{11}} \]

where \( a \) and \( c \) are lattice parameters and \( S_{11}, \ S_{33}, \ S_{13} \) and \( S_{44} \) are the elastic compliance of ZnO with values of \(7.858 \times 10^{-12}, -2.206 \times 10^{-12}, 6.940 \times 10^{-12} \) and \( 23.57 \times 10^{-12} \) m²N⁻¹, respectively [26]. The USDMs for Cr-doped ZnO are also plotted in Figure 4. Using the linear fits of Figure 4, the strain in anisotropic hexagonal crystals is calculated from the peak position, which is different from the USDM and UDM, their values are tabulated in Table 1.

Table 1. The average crystallite size, Young’s modulus strain, stress, and anisotropic energy density of Cr-doped nanocrystalline ZnO particles calculated using William-Hall approximation.

<table>
<thead>
<tr>
<th>Sample</th>
<th>at.%</th>
<th>( \langle D \rangle ) nm</th>
<th>( \varepsilon )</th>
<th>Young’s Modulus</th>
<th>Strain</th>
<th>Stress</th>
<th>Anisotropic Energy Density</th>
</tr>
</thead>
<tbody>
<tr>
<td>Cr doped ZnO</td>
<td>3</td>
<td>22</td>
<td>18</td>
<td>0.0007</td>
<td>17</td>
<td>71</td>
<td>0.0009</td>
</tr>
<tr>
<td></td>
<td>7</td>
<td>20</td>
<td>15</td>
<td>0.0001</td>
<td>16</td>
<td>64</td>
<td>0.0008</td>
</tr>
<tr>
<td></td>
<td>12</td>
<td>18</td>
<td>15</td>
<td>0.0001</td>
<td>15</td>
<td>11</td>
<td>0.0002</td>
</tr>
<tr>
<td></td>
<td>16</td>
<td>17</td>
<td>14</td>
<td>0.0003</td>
<td>13</td>
<td>9</td>
<td>0.0001</td>
</tr>
</tbody>
</table>

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In UDM, we have considered that the crystal is homogeneous isotropic, whereas in USDM, the assumption of homogeneity and isotropy is not fulfilled. Additionally, all of the constants proportionality associated with the stress-strain relation are no longer independent when the strain energy density, \( u \), is considered. According to Hook’s law the energy density is connected to the Young’s modulus through the equation:

\[
\frac{\varepsilon^2 E_{\text{Und}}} {2} = \frac{K}{D} + 4\sin\theta \left(\frac{2u}{E_{\text{Und}}^{1/2}}\right)
\]

Therefore Equation (7) should be modified to the form:

\[
\beta_{\text{Und}} \cos \theta = \frac{K}{D} + 4\sin\theta \left(\frac{2u}{E_{\text{Und}}^{1/2}}\right)
\]

The anisotropic energy density, \( u \), can be estimated from the slope of the curve \( \beta_{\text{Und}} \cos \theta \) as a function of \( 4\sin\theta (2/E_{\text{Und}})^{1/2} \). The average crystallite size can be obtained from the intercept and the strain from \( s/E_{\text{Und}} \). The variation of average crystallite size, strain lattice, stress and anisotropic energy density along with the Cr concentrations is shown in Table 1. The crystallite size calculated using Scherrer’s formula differs slightly from that obtained from the UDM, USDM and UDEDM. It was observed that the strain and stress values decreased with decreasing average crystallite size as the dopant concentration was increased.

3.4. Optical Properties

To study the electronic interactions near the optical band gap region due to the presence of dopants diffuse-reflectance measurements were performed on the samples in the UV-Vis region at room temperature.

All spectra were obtained in the range of 200 - 800 nm. Figure 5 shows the diffuse-reflectance spectra, R, as a function of the wavelength for the samples shown in Figure 2. The bandgap energy of the doped ZnO samples was calculated from the diffuse-reflectance spectra by plotting the square of the Kubelka-Munk function [27] \( F(R') \) vs. the energy in electron volts. The linear part of the curve was extrapolated to \( F(R') = 0 \) to calculate the direct bandgap energy. The inset of Figure 5 shows the bandgap as a function of the doping concentrations. The absorption edge shifts to lower energies/longer wavelengths. A similar shift in the absorption edge and band gap energy upon TM doping was reported in Co-, Ni-, and Mn-doped ZnO nanoparticles [28-30] as well as in other TM-doped semiconductor nanoparticle systems [31-33].

Additionally to the reduction in the band gap energy, a decrease in the diffuse reflectance was also observed with increasing dopant concentration. A change in the band gap can be explained by the variation in the lattice parameters as a result of doping. The systematic variation of the diffuse-reflectance near the band edge for the doped samples in comparison with the undoped sample is a further confirmation of Cr ion incorporation in the ZnO lattice. The presence of Cr in the ZnO lattice is also consistent with our EDX results (Figure 1). Although the corresponding results were explained in terms of changes.
in the lattice parameters, other groups [34-36] argued that this factor is not likely to significantly influence the bandgap energy. They reported that the red shift in the bandgap energy of transition-metal-doped II-VI semiconductors is attributed to the sp-d spin exchange interaction between the band electrons and the localized d-electrons of the transition metal ion that substitutes the cation.

The exchange constant that constantly involves the s-like states decreases the energy of the bottom conduction band, the exchange factor involving the p-like states increases the energy of the top valence band by a constant factor that is independent of temperature.

3.5. Electron Spin Resonance Study

The ESR spectra for synthesized Cr-doped ZnO at various composition observed at room temperature are shown in Figure 6. The spectra for all samples exhibited a very broad linewidth. The line width and intensity increased with increasing Cr content. All spectra had a symmetrical Lorentzian shape and have a similar line-shape. A stable electronic configuration of a free Cr atom is $3d^5\ 4s^1$, rather than $3d^4\ 4s^2$. As a dopant of the ZnO matrix, Cr can be incorporated in several ways [37]: 1) the electronic configuration of Cr can be $3d^4\ 4s^2$, with the two 4s electrons incorporated in the tetrahedral bonding scheme, resulting in $Cr^{2+}$ as an isoelectronic center; 2) a $3d^5\ 4s^2$ configuration can be formed by borrowing an electron from the valence band of the host with only one 4s electron of Cr being incorporated in the tetrahedral bonding scheme, resulting in $Cr^+$ and causing the other ‘borrowed’ electron from the valence band to result in a negatively charged center to which the hole is bound; 3) Cr can also have a $3d^3$ configuration, where the $Cr^{3+}$ ion can incorporate one 4s and one 3d electron into the bonding scheme, while another 3d is donated to the conduction band (making Cr a single donor), leaving the Cr center positively charged and able to bind the free electron.

Considering the earlier works on ESR spectroscopy of II-VI compounds [38,39], one usually relates the ESR spectra detected in the Cr-doped II-VI semiconductors to the Cr$^{2+}$ valance state. Therefore, it is also expected that the Cr$^{2+}$ ion in the Cr-doped ZnO will substitute for the Zn ion. However, our g-value and the peak-to-peak line width are in contradiction with the reported values of the ESR spectra of Cr$^{2+}$ in II-VI compounds. Vallin et al. [40] showed that the Cr$^{2+}$ ESR spectra in II-VI compounds have peak-to-peak line widths of 500 G at 20 K. Therefore, the expectation is that at room temperature, ESR signal of Cr$^{2+}$ will be broader and unable to observed [41]. Additionally, a study of Cr doped GaAs [42] revealed that the Cr$^{3+}$ valence state is predominant if the chromium concentration significantly exceeds the concentration of shallow donors in the crystal.

Therefore, we believed that our ESR signal arose from the Cr$^{3+}$ centers instead of the Cr$^{2+}$ ions. A similar result was also obtained by Krishnaiah et al. [43] in ZnCrTe crystals. All spectra lines were centered at approximately 550 G, corresponding to an effective g-value of 1.989 which is attributed to the typical value of Cr$^{3+}$ ions [42,45]. All of the g-values of the spectrum observed in Cr-doped ZnO correspond not only to the Cr$^{3+}$ ions.
observed in Cr-doped II-VI compounds, but also to an unpaired electron trapped at an oxygen vacancy site. It is possible that the broad line of the Cr$^{3+}$ ions overlap with the resonance line of an unpaired electron trapped on an oxygen vacancy site. However, the deconvolution would be problematic because an accurate estimate of the intensity under the broad resonance line is difficult.

3.6. Magnetic Characterization

The magnetic properties of the Cr-doped ZnO samples were investigated using VSM in the magnetic field range of 0 to ±1 T. The magnetization (M) versus the magnetic field (H) measured at room temperature is illustrated in Figure 7. The magnetization is plotted as a function of magnetic field for different doping concentrations. All of the Cr-doped samples in this study exhibit ferromagnetic behavior.

An interesting feature is observed when we analyze the magnetization data of Cr-doped samples studied in this work. The 7, 12 and 16 at.% Cr-doped samples showed a remnant magnetizations of 0.35, 0.35, and 0.34 ($\times 10^{-2}$) emu/g and coercive field of 482, 322 and 164 Oe, respectively. The magnetization increased for samples doped with higher Cr concentrations. The 7 at.%, 12 at.% and 16 at.% Cr-doped samples possessed net moments of 0.060, 0.077 and 0.144 $\mu_B$/Cr, respectively. The Cr-doped samples also had net moments far below the theoretical values. However, only a small fraction of Cr atoms contribute to ferromagnetism. The low magnetic moment values might be a result of the competition between the ferromagnetic and antiferromagnetic coupling that occurs at short distances between a pair of Cr ions.

Similar to ZnO doped with other transition metals, the secondary phase in our samples is thought to be the source of the spurious magnetic signal. In principle, as the Cr concentration increases, a number of antiferromagnetic phases may occur, such as ZnCr$_2$O$_4$ (T$_N$ 11K), Cr metal clusters, Cr$_2$O$_3$ and Cr$_3$O$_4$[46-48]. However, none of the phases can be detected via XRD. Even, if these phases are present in small quantities, none of them to ferromagnetism, except the Cr$_2$O$_3$ phase (T$_C$ ~368 K) [49]. Therefore, room temperature ferromagnetism in our Cr-doped sample cannot be explained by the secondary phases. Xu et al. [50] observed ferromagnetism in Cr-doped ZnOnanorods. They observed a uniform incorporation of Cr into Zn with no secondary phases and suggested that the combined effects of structural defects and exchange interactions of the Cr ions substituting for Zn in the ZnO matrix were responsible for the magnetization in their Cr-doped ZnO samples.

The existence of compressive stress/and/or strain due to the oxygen vacancies may also be a factor that to influences the shift of the XRD peaks position. Defects are known to play a primary role in ferromagnetic ordering in transition-metal-doped semiconductors such as ZnO [23,46,51]. An increasing number of studies have demonstrated that the formation of oxygen vacancies and zinc interstitial could lead to room temperature ferromagnetism or enhanced ferromagnetism [52-54]. According to the donor impurity band exchange model, the ferromagnetic-exchange between transition-metal ions and semiconductors is mediated by shallow donor electrons that form bound magnetic polarons which overlap to create a spin-split impurity band.

With regard to the origin of the ferromagnetism observed in our samples and considering the above measurements, we conclude that ferromagnetism in our Cr-doped samples is an intrinsic property of Cr-doped ZnO. Our data support the hypothesis that the magnetic behavior observed is related to the presence of intrinsic defects. This can be understood via the BMP model discussed above.

4. Summary

In summary, a series of Cr-doped ZnO nanoparticle samples with different doping concentrations were success-
fully synthesized and characterized by EDX, XRD, UV-Vis, ESR and VSM. The XRD patterns suggested the formation of a wurtzite structure in the Cr-doped ZnO. The XRD results also indicated that Cr-ions were incorporated into the ZnO matrix. The XRD line broadening due to the combination of the coherent scattering of X-rays from a particular lattice plane and the random displacement of atoms from their original positions, which generates strain was analyzed by Scherrer’s formula and by a modified form of W-H analysis. The three modified W-H analyses were helpful in approximating the strain, stress and energy density values. The results show that the strain, stress and energy density values decreased with increasing doping concentrations.

The magnetic measurements show that the Cr-doped ZnO samples are ferromagnetic in nature with a well-defined hysteresis at room temperature and the coercive field (Hc) and the remnant magnetization increase with increasing doping concentrations. The analysis shows that the room temperature ferromagnetic in Cr-doped ZnO might be explained by BMP model.

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